Notice of References C	ited
------------------------	------

Application/Control No. 10/526,958	Reexamination	Applicant(s)/Patent Under Reexamination NAKATA ET AL.		
Examiner	Art Unit			
Andrew C. Lee	2476	Page 1 of 3		

#### U.S. PATENT DOCUMENTS

	U.S. FATENT DOCUMENTS					
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification	
*	Α	US-6,430,160	08-2002	Smith et al.	370/252	
*	В	US-7,457,868	11-2008	Guo, Qing	709/224	
*	С	US-6,707,821	03-2004	Shaffer et al.	370/395.4	
*	D	US-6,741,569	05-2004	Clark, Alan Douglas	370/252	
*	Е	US-6,580,694	06-2003	Baker, Carl R.	370/252	
*	F	US-6,958,977	10-2005	Mitrani et al.	370/252	
*	G	US-7,012,890	03-2006	Yazaki et al.	370/229	
*	н	US-6,674,726	01-2004	Kado et al.	370/253	
*	_	US-7,206,861	04-2007	Callon, Ross W	709/242	
*	J	US-6,347,091	02-2002	Wallentin et al.	370/437	
*	к	US-6,757,255	06-2004	Aoki et al.	370/252	
*	L	US-6,208,643	03-2001	Dieterich et al.	370/389	
*	М	US-5,247,464	09-1993	Curtis, Robert A.	379/25	

# FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

#### NON-PATENT DOCUMENTS

	NON-FATENT DOCUMENTS						
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U						
	٧						
	w						
	х						

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References (	Cited
------------------------	-------

Application/Control No. 10/526,958	Applicant(s)/Patent Under Reexamination NAKATA ET AL.		
Examiner	Art Unit		
Andrew C. Lee	2476	Page 2 of 3	

# U.S. PATENT DOCUMENTS

	C.S. I ATEN DOCUMENTS					
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification	
*	Α	US-6,707,821	03-2004	Shaffer et al.	370/395.4	
*	В	US-6,985,501	01-2006	Suzuki et al.	370/517	
*	С	US-7,012,893	03-2006	Bahadiroglu, Murat I.	370/231	
*	D	US-7,765,321	07-2010	Twata et al.	709/238	
*	Е	US-7,082,124	07-2006	Katukam, Suresh	370/357	
*	F	US-7,111,074	09-2006	Basturk, Erol	709/241	
*	G	US-2004/0073655	04-2004	Kan et al.	709/224	
*	Н	US-2006/0018321	01-2006	Yamada et al.	370/392	
*	T	US-7,660,241	02-2010	Sridhar et al.	370/229	
*	J	US-6,765,873	07-2004	Fichou et al.	370/235	
*	к	US-6,850,498	02-2005	Heath et al.	370/328	
*	L	US-7,508,769	03-2009	Duffield et al.	370/252	
*	М	US-5,687,167	11-1997	Bertin et al.	370/254	

# FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν					
	0					
	Р					
	a					
	R					
	s					
	т					

NON-PATENT DOCUMENTS						
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	v					
	w					
	х					

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	1
----------------------------	---

Application/Control No. 10/526,958	Applicant(s)/Patent Under Reexamination NAKATA ET AL.		
Examiner	Art Unit		
Andrew C. Lee	2476	Page 3 of 3	

# U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-7,296,083	11-2007	Barham et al.	709/232
*	В	US-5,582,860	12-1996	Fontana et al.	427/130
*	С	US-7,376,731	05-2008	Khan et al.	709/224
	D	US-			
	Е	US-			
	F	US-			
	G	US-		-	
	Н	US-			
	T	US-		_	
	J	US-			
	к	US-			
	٦	US-			
	М	US-			

#### FOREIGN PATENT DOCUMENTS

TOTAL AT EAT BOOMETTO									
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification			
	N								
	0								
	Р								
	Q								
	R								
	s								
	т								

### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
Ī	U	
	v	
	w	
	х	

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.